

## MOSFET

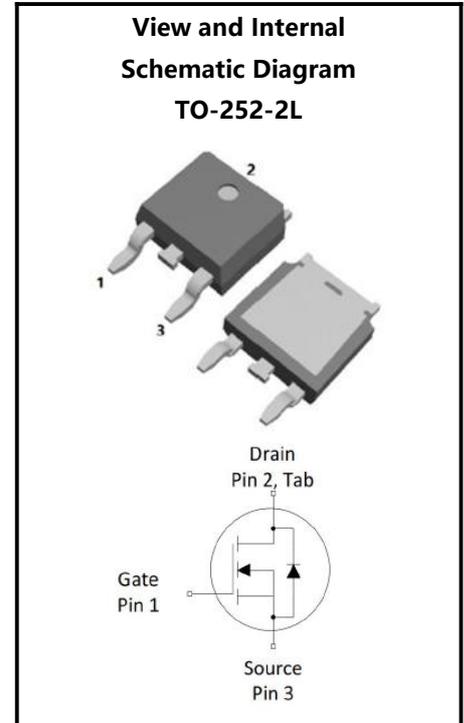
186A ,40V ,2.2mΩ N-CHANNEL MOSFET

### Features

- ◆ Extremely low on-resistance  $R_{DS(on)}$
- ◆ Excellent Low Ciss

### Applications

- ◆ Synchronous Rectification for AC/DC Quick Charger
- ◆ Battery management
- ◆ UPS(Uninterruptible Power Supplies)



Parameter	Values	Unit
$V_{DSS}$	40	V
$I_D$	186	A
$R_{Dson(max)}$	2.2	mΩ
$V_{GS(th)(Typ)}$	1.8	V

Ordering Code	Marking	Package	Packaging
X2P2N040GLE2	X2P2N040GLE2	TO-252-2L	Tape and Reel

### Absolute Maximum Ratings( $T_C=25^{\circ}C$ , unless otherwise noted)

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Drain-Source Voltage	$V_{DSS}$	-	-	40	V	-
Gate-Source Voltage	$V_{GS}$	-20	-	20	V	-
Continuous Drain Current(Note 1)	$I_D$	-	-	186	A	$T_C=25^{\circ}C$
		-	-	118	A	$T_C=100^{\circ}C$
Pulsed Drain Current(Note 2)	$I_{DM}$	-	-	744	A	-
Single Pulse Avalanche Energy	$E_{AS}$	-	-	121	mJ	$L=0.5mH, V_D=32V, T_C=25^{\circ}C$
Maximum Power Dissipation	$P_D$	-	-	127	W	$T_C=25^{\circ}C$
		-	-	1.1	W	$T_A=25^{\circ}C$
Operating Junction and Storage Temperature Range	$T_{j}, T_{STG}$	-55	-	150	$^{\circ}C$	-

### Thermal Characteristics

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Thermal resistance , Junction to Case	$R_{th(j-c)}$	-	-	1	$^{\circ}C/W$	-
Thermal resistance , Junction to Ambient	$R_{th(j-a)}$	-	-	112	$^{\circ}C/W$	-

## Electrical Characteristics ( $T_j=25^{\circ}\text{C}$ , unless otherwise noted)

### Static characteristics

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Drain-Source Breakdown Voltage	$BV_{DSS}$	40	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Zero Gate Voltage Drain Current	$I_{DSS}$	-	-	1	$\mu A$	$V_{DS}=40V, V_{GS}=0V$
Gate-Body Leakage Current, Forward	$I_{GSSF}$	-	-	100	nA	$V_{GS}=20V, V_{DS}=0V$
Gate-Body Leakage Current, Reverse	$I_{GSSR}$	-	-	-100	nA	$V_{GS}=-20V, V_{DS}=0V$
Gate-Source Threshold Voltage	$V_{GS(th)}$	1.2	-	2.4	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Drain-Source On-State Resistance	$R_{DS(on)}$	-	1.7	2.2	m $\Omega$	$V_{GS}=10V, I_D=20A$
		-	2.8	3.5	m $\Omega$	$V_{GS}=4.5V, I_D=20A$
Gate Resistance	$R_g$	-	1.9	-	$\Omega$	$V_{GS}=0V, V_{DS}=0V, f=1\text{MHz}$
Forward Transconductance	$g_{fs}$	-	45	-	S	$V_{DS}=5V, I_D=20A$

### Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Input Capacitance	$C_{iss}$	-	3983	-	pF	$V_{DS}=20V, V_{GS}=0V, f=1.0\text{MHz}$
Output Capacitance	$C_{oss}$	-	1461	-		
Reverse Transfer Capacitance	$C_{rss}$	-	174	-		
Turn-On Delay Time	$t_{d(on)}$	-	0.6	-	ns	$V_{DD}=20V, R_G=2.2\Omega, V_{GS}=10V, I_D=29A$
Turn-On Rise Time	$t_r$	-	1.4	-		
Turn-Off Delay Time	$t_{d(off)}$	-	54.8	-		
Turn-Off Fall Time	$t_f$	-	2.2	-		

### Gate charge characteristics

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Total Gate Charge	$Q_g$	-	74	-	nC	$V_{DS}=20V, I_D=50A, V_{GS}=10V$
Gate-Source Charge	$Q_{gs}$	-	16	-		
Gate-Drain Charge	$Q_{gd}$	-	16	-		

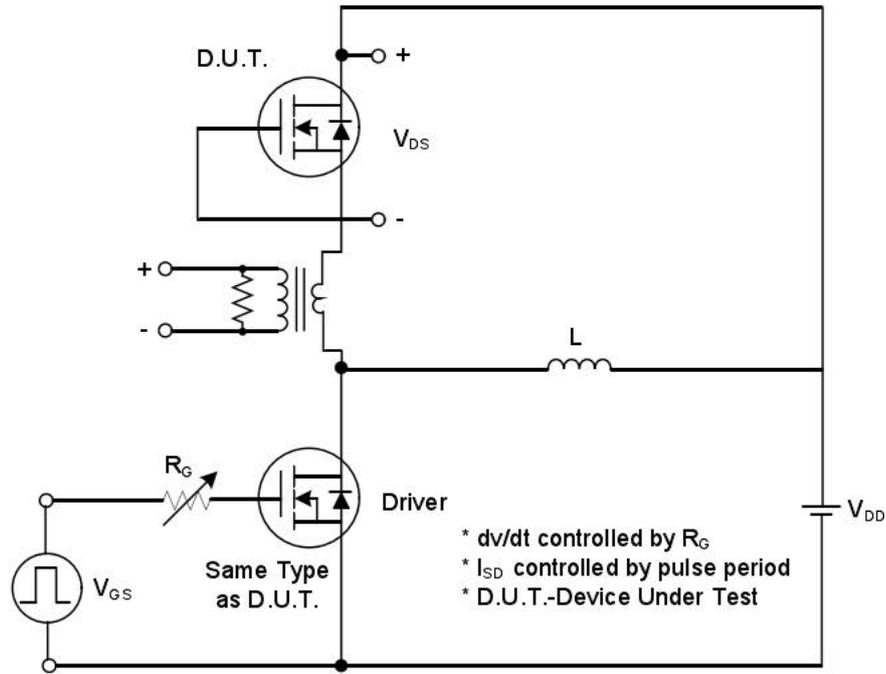
### Reverse diode

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Continuous Diode Forward Current	$I_S$	-	-	186	A	-
Pulsed Diode Forward Current	$I_{SM}$	-	-	744	A	-
Diode Forward Voltage	$V_{SD}$	-	0.8	1.2	V	$I_S=20A, V_{GS}=0V$
Reverse Recovery Time	$t_{rr}$	-	98	-	ns	$V_{DS}=27V, V_{GS}=0V, I_S=20A,$
Reverse Recovery Charge	$Q_{rr}$	-	258	-	nC	$di/dt=100A/\mu s$

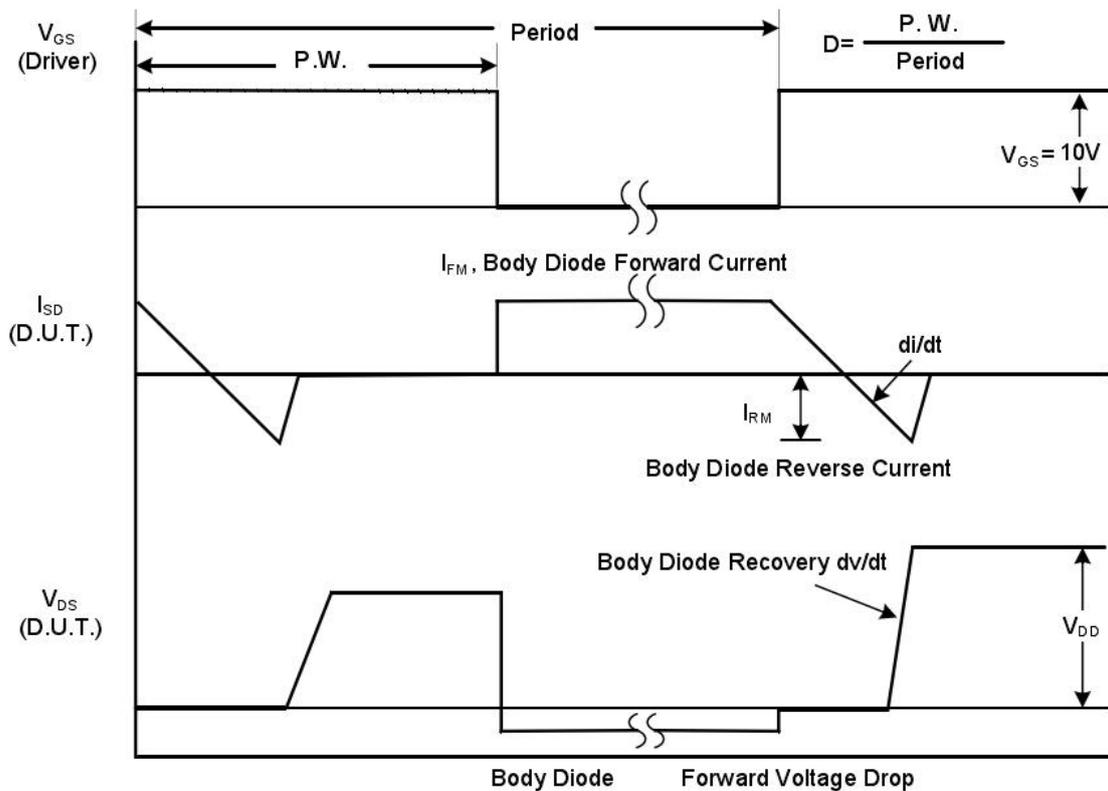
### Notes

1. Computed continuous current assumes the condition of  $T_{j\_Max}$  while the actual continuous current depends on the thermal & electro-mechanical application board design.
2. This single-pulse measurement was taken under  $T_{j\_Max} = 150^{\circ}\text{C}$ .

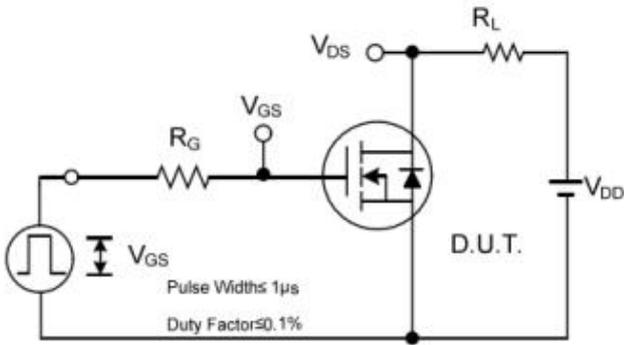
RATING AND CHARACTERISTIC CURVES



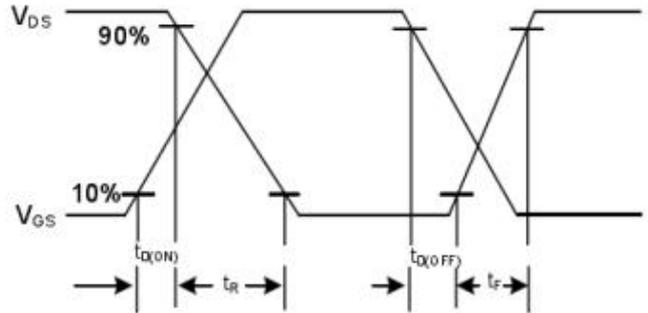
Peak Diode Recovery dv/dt Test Circuit



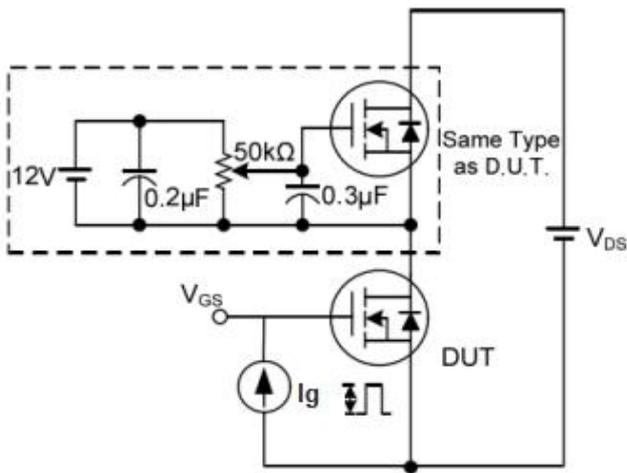
Peak Diode Recovery dv/dt Waveforms



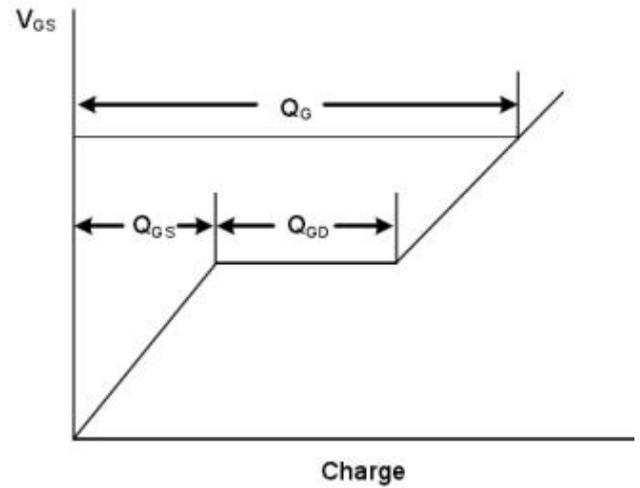
Switching Test Circuit



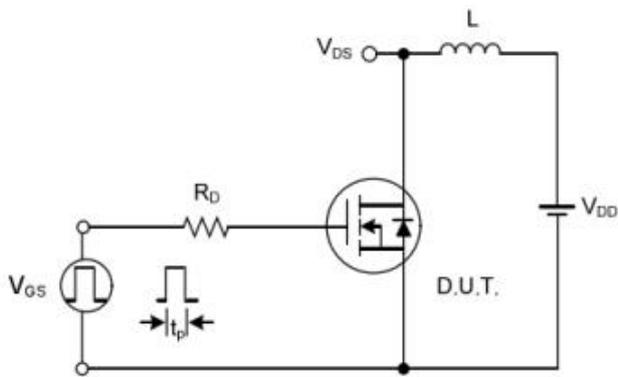
Switching Waveforms



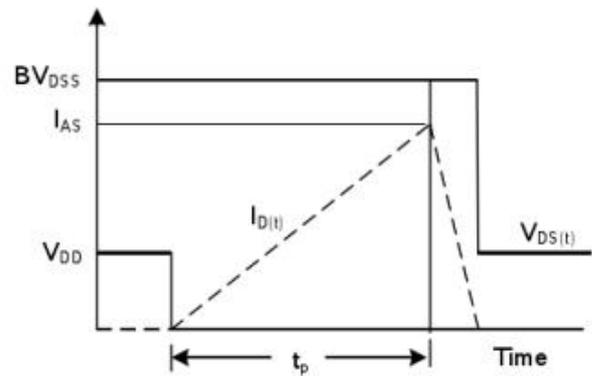
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

## RATING AND CHARACTERISTIC CURVES

Figure.1 Output Characteristics

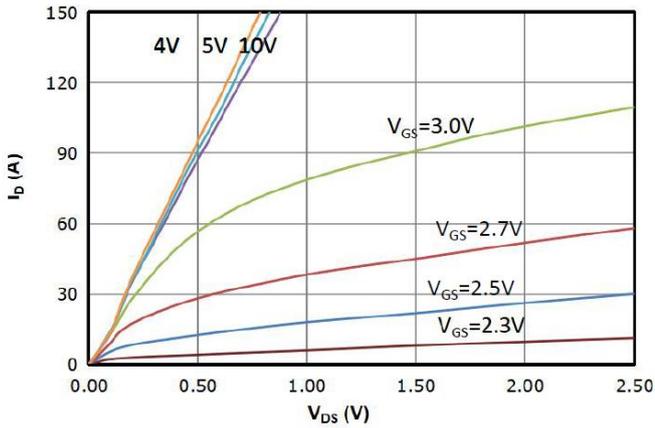


Figure.2 Transfer Characteristic

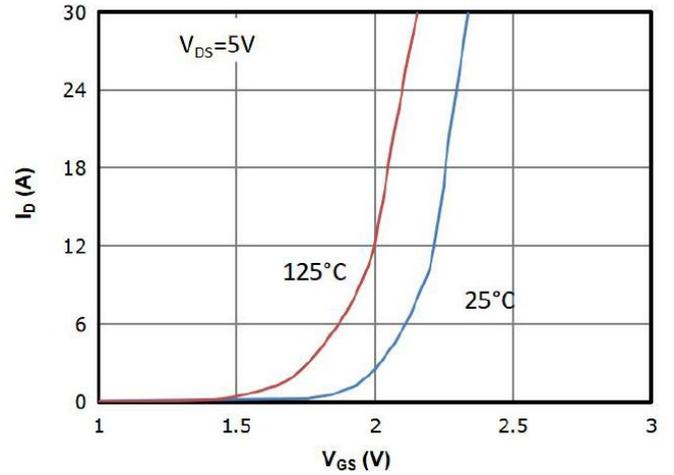


Figure.3 On-Resistance vs Drain Current For Various Gate Voltage

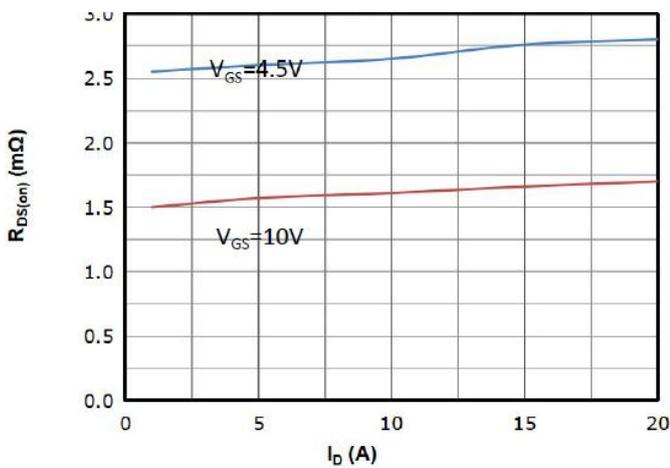


Figure.4 On-Resistance vs Gate Voltage For Various Temperatures

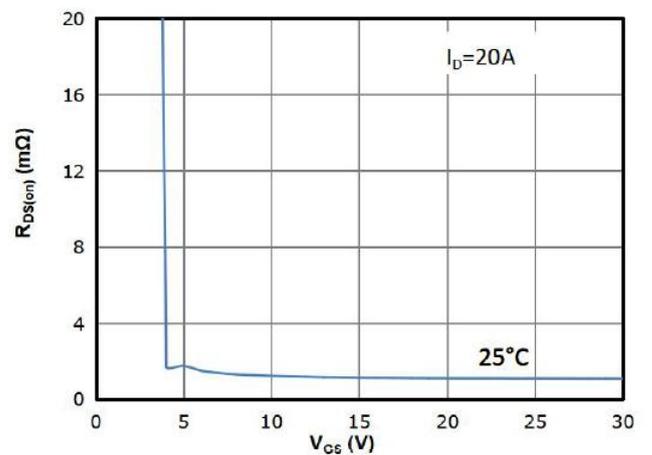


Figure.5 Typical On-Resistance vs Junction Temperature

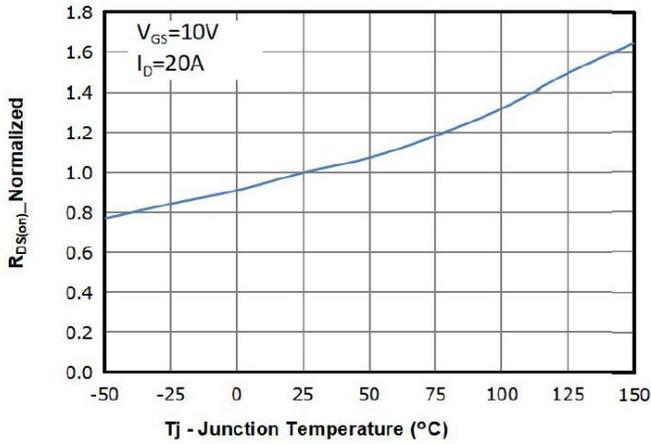


Figure.6 Typical Threshold Voltage vs Junction Temperature

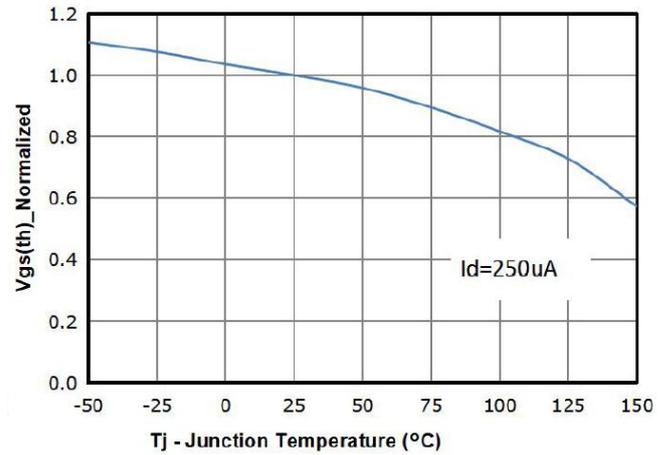


Figure.7 Typical Breakdown Voltage vs Junction Temperature

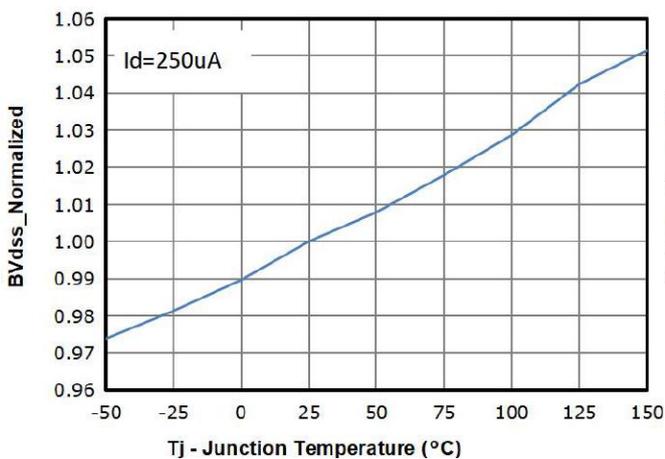


Figure.8 Typical Capacitance vs Drain to Source Voltage

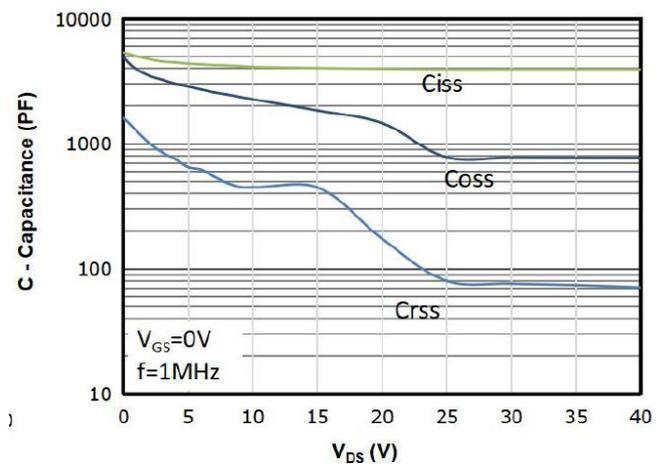


Figure.9 Typical Gate Charge vs Gate to Source Voltage

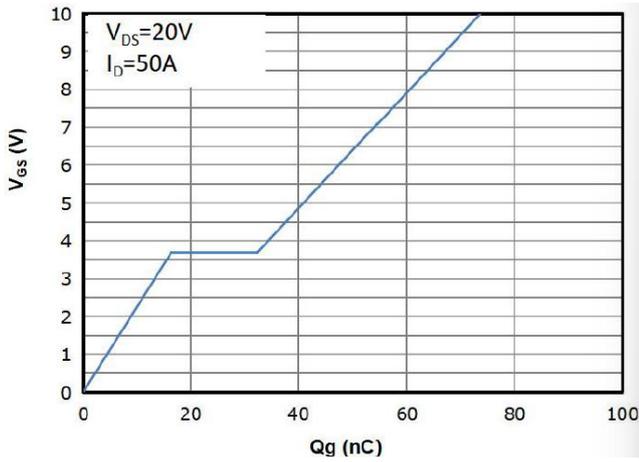


Figure.10 Typical Body Diode Characteristics

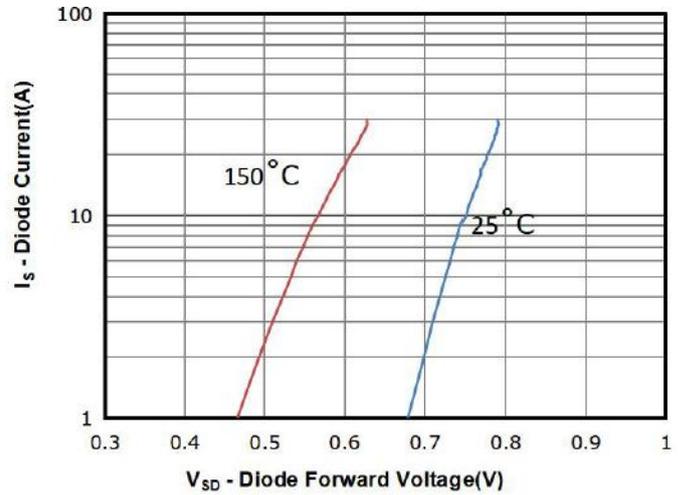


Figure.11 Maximum Power Dissipation Derating vs Case Temperature

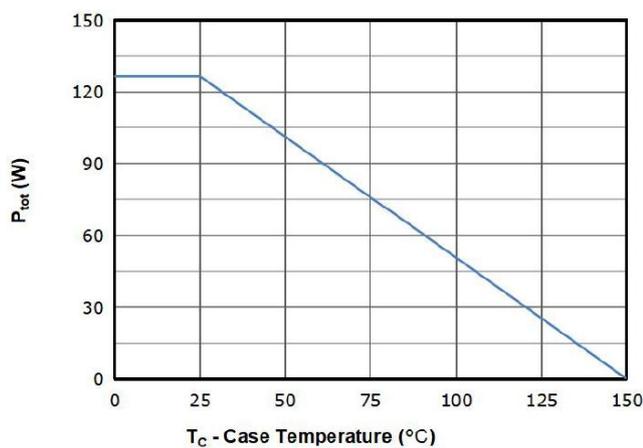


Figure.12 Continuous Drain Current Derating vs Case Temperature

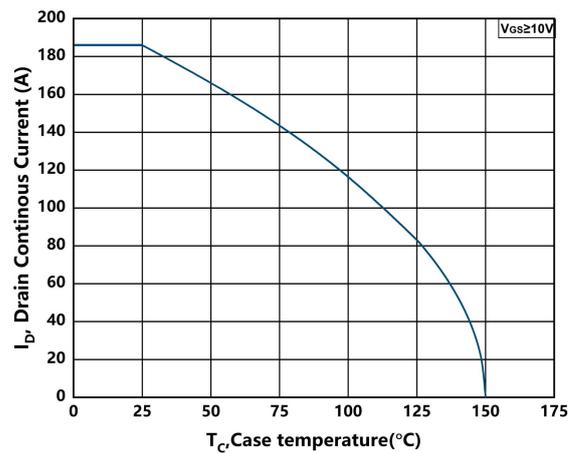


Figure.13 Safe Operating Area

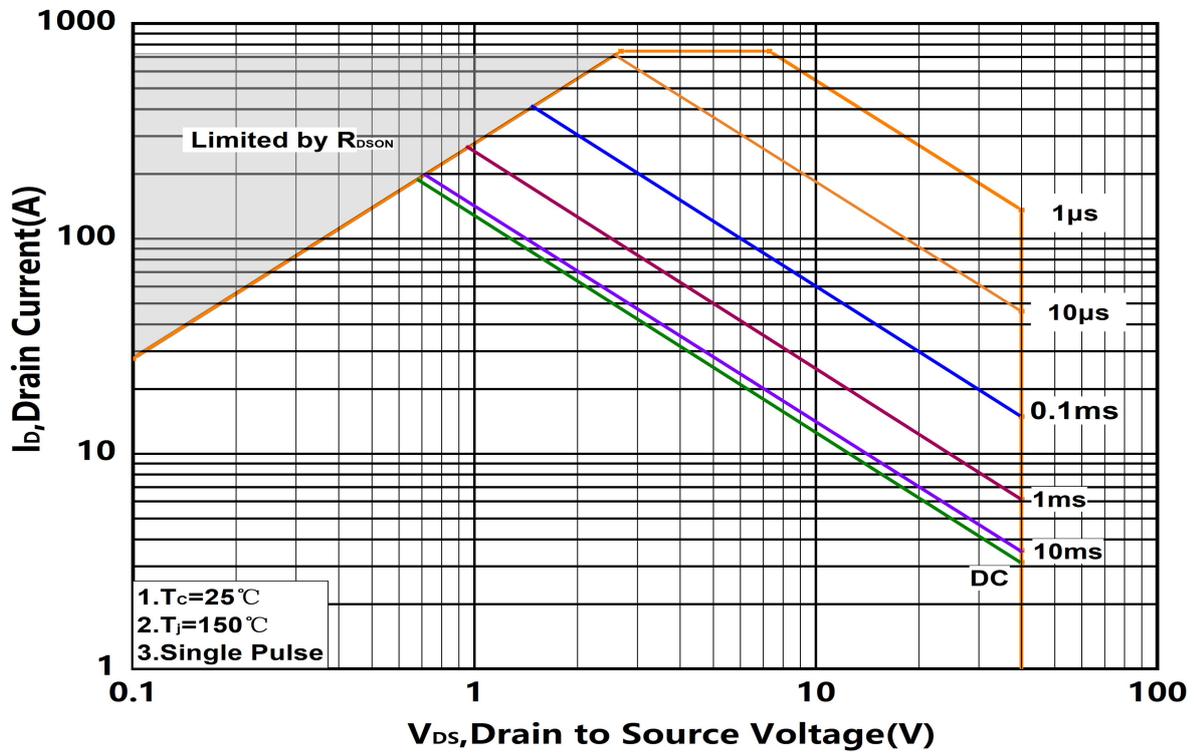
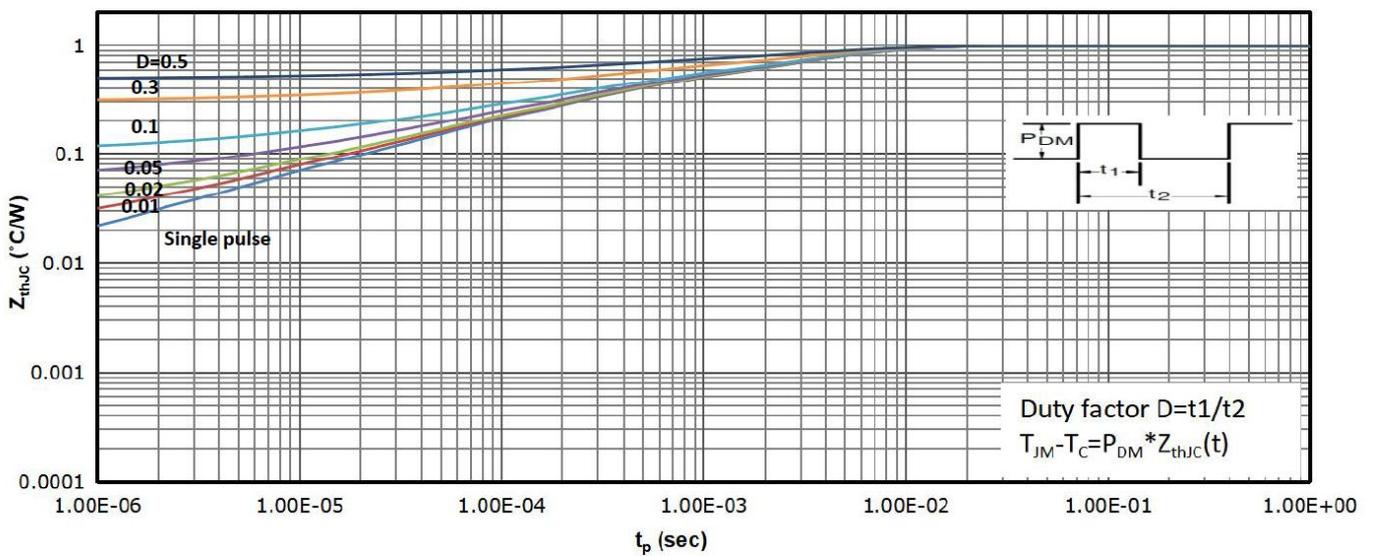
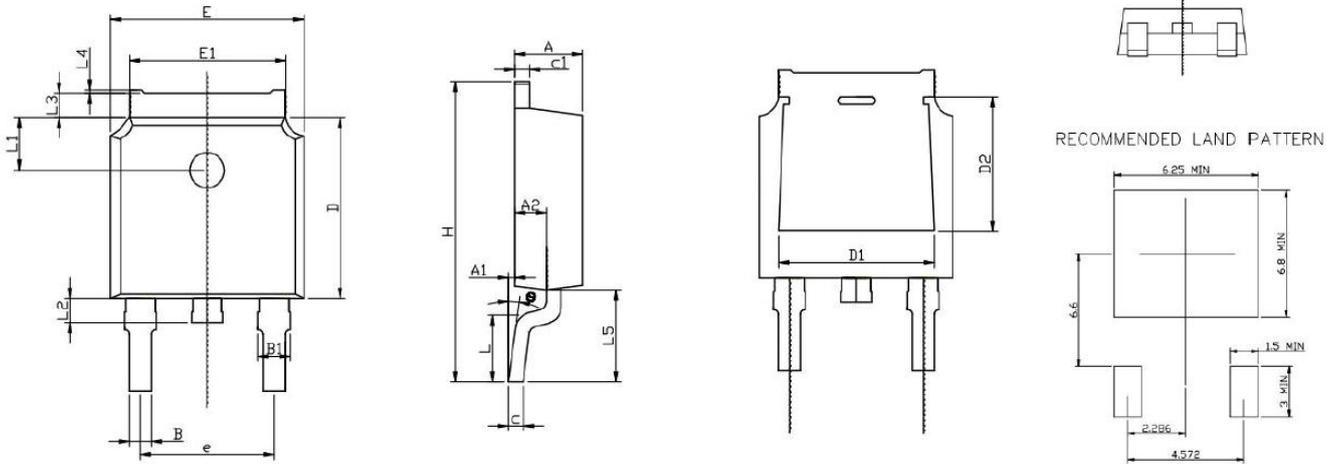


Figure.14 Transient Thermal Impedance (Junction - Case)





Package Outline: TO-252-2L



UNIT: mm

SYMBOL	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.15	2.45	0.085	0.096
A1	0.05	0.20	0.002	0.008
A2	0.91	1.22	0.036	0.048
B	0.66	0.86	0.026	0.034
B1	0.93	1.23	0.037	0.048
C	0.40	0.60	0.016	0.024
C1	0.40	0.60	0.016	0.024
D	5.95	6.25	0.234	0.246
D1	4.80		0.189	
D2	3.80		0.150	
E	6.45	6.75	0.254	0.266
E1	5.12	5.52	0.202	0.217
L	1.65		0.065	
L1	1.58	1.98	0.062	0.078
L2	0.60	1.00	0.024	0.039
L3	0.70	1.00	0.028	0.039
L4	0.00	0.20	0.000	0.008
L5	2.80	3.40	0.110	0.134
H	9.80	10.40	0.386	0.409
θ	0.00	8.00	0.000	0.315
e	4.57		0.180	